

Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty. Docket No. SVIPGP002B	Application No.: 10/661,878
	Applicant: Keivn J. Zilka et al.	
	Filing Date: 09/11/2003	Group Art Unit: 3689

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub- class	Translation	
							Yes	No
	A	JP2002366797A	12/20/2002	JPO	G06F	17/60	X	
	B	JP08190572A	07-1996	JPO	G06F	17/30	X	
	C	GB2339374A	01/19/2000	GB	G06F	17/30	X	
	D	WO01/35277A1	05/17/2001	WIPO	G06F	17/30	X	
	E	WO02/05150A2	01/17/2002	WIPO	G06F	17/60	X	
	F	WO03/44718A2	30.05.2003	WIPO	G06F	17/60	X	
	G	WO97/17662	05/15/1997	WIPO	G06F	17/30	X	
	H	WO00/52618	09/08/2000	WIPO	G06F	17/60	X	
	I	WO98/55945	12/10/1998	WIPO	G06F	17/30	X	
	J	WO00/11575	03/02/2000	WIPO	G06F	17/30	X	
	K	WO01/73657	10/04/2001	WIPO	G06F	17/60	X	
	L	WO02/86744	10/31/2002	WIPO	G06F	15/16	X	
	M	WO02/59147	08/01/2002	WIPO	C07K	14/00	X	
	N	WO01/84425	11/08/2001	WIPO	G06F	17/60	X	
	O	WO01/84424	11/08/2001	WIPO	G06F	17/60	X	
	P	WO01/84423	11/08/2001	WIPO	G06F	17/60	X	
	Q	WO01/84426	11/08/2001	WIPO	G06F	17/60	X	
	R	WO01/54031	07/26/2001	WIPO	G06F	17/60	X	
	S	WO01/75851	12/14/2000	WIPO	G06F	17/60	X	
	T	WO00/60496	10/12/2000	WIPO	G06F	17/60	X	
	U	WO00/60495A2	10/12/2000	WIPO	G06F	17/00	X	
	V	WO00/60495A3	10/12/2000	WIPO	G06F	17/60	X	
	W	EP1030247 A2	8/23/2000	EPO	G06F	17/24	X	
Examiner /Dennis Ruhl/			Date Considered 07/31/2011					

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
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	B	5,297,039	03/1994	Kanaegami, et al	707	5	
	C	5,642,518	06/1997	Kiyama, et al	704	7	
	D	5,696,962	12/1997	Kupiec, Julian M.	707	4	

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	E	JP2002366797A	12/20/2002	JPO	G06F	17/60	X	
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	G	WO 01/35277A1	05/17/2001	WIPO	G06F	17/30	X	
	H	WO 02/05150A2	01/17/2002	WIPO	G06F	17/60	X	
	I	WO 03/044718A2	30.05.2003	WIPO	G06F	17/60	X	
	J	WO97/017662	05/15/1997	WIPO	G06F	17/30	X	
	K	WO00/052618	09/08/2000	WIPO	G06F	17/60	X	
	L	WO98/055945	12/10/1998	WIPO	G06F	17/30	X	
	M	WO00/011575	03/02/2000	WIPO	G06F	17/30	X	
	N	WO01/073657	10/04/2001	WIPO	G06F	17/60	X	
	O	WO02/086744	10/31/2002	WIPO	G06F	15/16	X	
	P	WO02/059147	08/01/2002	WIPO	C07K	14/00	X	
	Q	WO01/084425	11/08/2001	WIPO	G06F	17/60	X	
	R	WO01/084424	11/08/2001	WIPO	G06F	17/60	X	
	S	WO01/084423	11/08/2001	WIPO	G06F	17/60	X	
	T	WO01/084426	11/08/2001	WIPO	G06F	17/60	X	
	U	WO01/054031	07/26/2001	WIPO	G06F	17/60	X	
	V	WO01/075851	12/14/2000	WIPO	G06F	17/60	X	
	W	WO00/060496	10/12/2000	WIPO	G06F	17/60	X	
	X	WO00/060495	10/12/2000	WIPO	G06F	17/60	X	
	Y	WO00/060495	10/12/2000	WIPO	G06F	17/00	X	
	Z	WO00/052618	09/08/2000	WIPO	G06F	17/30	X	

Examiner	/Dennis Ruhl/	Date Considered	07/31/2011
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